

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/722,425	IOI NOBUYASU	
Examiner	Art Unit	
Christopher H. Orders	3746	

SEARCHED				
Class	Subclass	Date	Examiner	
417	410.5	3/30/2005	сно	
	371	3/31/2005	СНО	
310	201	3/30/2005	сно	
	51	3/30/2005	СНО	
	54	3/30/2005	СНО	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u>L</u>			

SEARCH N (INCLUDING SEARC		)
	DATE	EXMR
East Text Search	3/30/2005	сно
Consulted Tim Solak	3/30/2005	сно
Consulted Karl Tamai	3/30/2005	сно